


<b>Search Notes</b>  	<b>Application/Control No.</b>  10535332	<b>Applicant(s)/Patent Under Reexamination</b>  FUCHS ET AL.
	<b>Examiner</b>  Lee, Shun	<b>Art Unit</b>  2884

SEARCHED			
Class	Subclass	Date	Examiner
250	361R	1/16/2007	/SL/
250	488.1	1/16/2007	/SL/
Above	UPDATED	6/18/2007	/SL/

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, IBM_TDB) - See Search History Printout	6/18/2007	/SL/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	PGPUB text search - see interference search history printout	6/18/2007	/SL/